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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)				Application Number	10/700300-Conf. #2702
				Filing Date	October 31, 2003
				First Named Inventor	Marvin L. VESTAL
				Art Unit	2881
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	SY9-195

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
KP	A1	US-RE37,485	12-25-2001	Vestal	
	A2	US-5,498,545	03-12-1996	Vestal	
	A3	US-5,625,184	04-29-1997	Vestal et al.	
	A4	US-5,627,369	05-06-1997	Vestal et al.	
	A5	US-5,821,063	10-13-1998	Patterson et al.	
	A6	US-5,864,137	01-26-1999	Becker et al.	
	A7	US-5,955,731	09-21-1999	Bergmann et al.	
	A8	US-6,002,127	12-14-1999	Vestal et al.	
	A9	US-6,057,543	05-02-2000	Vestal et al.	
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	A11	US-6,348,688	02-19-2002	Vestal	
	A12	US-6,441,369	08-27-2002	Vestal et al.	
	A13	US-6,504,150	01-07-2003	Verentchikov et al.	
	A14	US-6,512,225	01-28-2003	Vestal et al.	
	A15	US-6,534,764	03-18-2003	Verentchikov et al.	
	A16	US-6,541,765	04-01-2003	Vestal	
KP	A17	US-6,545,268	04-08-2003	Verentchikov et al.	

FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No. ¹	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)					

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
KP	C1	"High-Throughput STR Analysis by Time-of-Flight Mass Spectrometry," John M. Butler, Kathryn M. Stephens, Joseph A. Monforte, Christopher H. Becker, GeneTrace Systems Inc., 1401 Harbor Bay Parkway, Alameda, CA 94502, downloaded August 2003 from www.promega.com .	
KP	C2	"STR Analysis by Time-of-Flight Mass Spectrometry" By John M. Butler, Ph.D. GeneTrace Systems Inc., 1401 Harbor Bay Parkway, Alameda, CA, downloaded August 2003 from www.promega.com	

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Examiner Signature		Date Considered	12-12-04
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